# DATA SHEET

# MOS FIELD EFFECT TRANSISTORS **2SK2359/2SK2360**

## SWITCHING N-CHANNEL POWER MOS FET INDUSTRIAL USE

#### DESCRIPTION

The 2SK2359, 2SK2359-Z/2SK2360, 2SK2360-Z is N-Channel MOS Field Effect Transistor designed for high voltage switching applications.

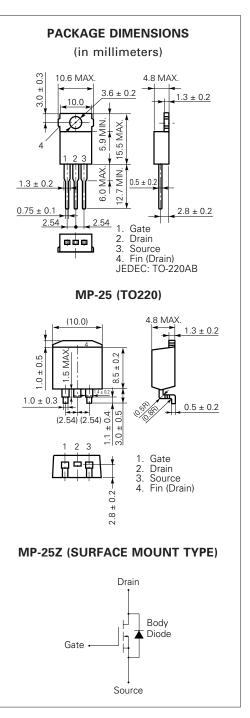
#### **FEATURES**

- Low On-Resistance 2SK2359:  $R_{DS(on)} = 0.9 \ \Omega \ (V_{GS} = 10 \ V, \ I_D = 4.0 \ A)$ 2SK2360:  $R_{DS(on)} = 1.0 \ \Omega \ (V_{GS} = 10 \ V, \ I_D = 4.0 \ A)$
- Low Ciss Ciss = 1050 pF TYP.
- High Avalanche Capability Ratings

#### ABSOLUTE MAXIMUM RATINGS (TA = 25 °C)

| Drain to Source Voltage(2SK2359/2SK2360)                   | Vdss        | 450/500     | V  |
|--|-------------|-------------|----|
| Gate to Source Voltage                                     | Vgss        | ±30         | V  |
| Drain Current (DC)   | D(DC)       | ±7.0        | А  |
| Drain Current (pulse)*                                     | D(pulse     | ) ±28       | А  |
| Total Power Dissipation (T <sub>c</sub> = 25 $^{\circ}$ C) | Pt1         | 75          | W  |
| Total Power Dissipation (T <sub>A</sub> = 25 $^{\circ}$ C) | <b>Р</b> т2 | 1.5         | W  |
| Channel Temperature  | Tch         | 150         | °C |
| Storage Temperature  | Tstg        | –55 to +150 | °C |
| Single Avalanche Current**                                 | las         | 7.0         | А  |
| Single Avalanche Energy**                                  | Eas         | 17          | mJ |
| * PW $\leq$ 10 $\mu$ s, Duty Cycle $\leq$ 1 %              |             |             |    |

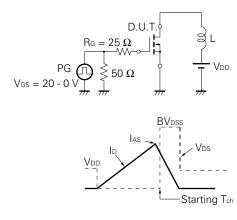
\*\* Starting T<sub>ch</sub> = 25 °C, R<sub>G</sub> = 25  $\Omega$ , V<sub>GS</sub> = 20 V  $\rightarrow$  0



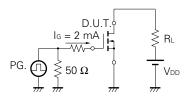
ELECTRICAL CHARACTERISTICS (TA = 25 °C)

| CHARACTERISTIC                      | SYMBOL               | MIN. | TYP. | MAX. | UNIT | TEST CONDITIONS                                 |          |
|-------------------------------------|----------------------|------|------|------|------|---|----------|
| Drain to Source On-State Resistance | RDS(on)              |      | 0.7  | 0.9  | mΩ   | $V_{GS} = 10 V$                                 | 2SK2359  |
|                                     |                      |      | 0.8  | 1.0  |      | $V_{D} = 4.0 V$                                 | 2SK2360  |
| Gate to Source Cutoff Voltage       | V <sub>GS(off)</sub> | 2.5  |      | 3.5  | V    | $V_{DS} = 10 V, I_D$                            | = 1 mA   |
| Forward Transfer Admittance         | y <sub>fs</sub>      | 3.0  |      |      | S    | $V_{DS} = 10 V, I_{D} = 4.0 A$                  |          |
| Drain Leakage Current               | loss                 |      |      | 100  | μΑ   | Vds = Vdss, Vgs = 0                             |          |
| Gate to Source Leakage Current      | Igss                 |      |      | ±100 | nA   | $V_{GS} = \pm 30 \text{ V}, \text{ V}_{DS} = 0$ |          |
| Input Capacitance                   | Ciss                 |      | 1050 |      | pF   | $V_{DS} = 10 V$                                 |          |
| Output Capacitance                  | Coss                 |      | 200  |      | pF   | Vgs = 0   |          |
| Reverse Transfer Capacitance        | Crss                 |      | 26   |      | pF   | f = 1 MHz                                       |          |
| Turn-On Delay Time                  | td(on)               |      | 14   |      | ns   | ID = 4.0 A                                      |          |
| Rise Time                           | tr                   |      | 9    |      | ns   | $V_{GS} = 10 V$                                 |          |
| Turn-Off Delay Time                 | td(off)              |      | 56   |      | ns   | Vdd = 150 V                                     |          |
| Fall Time                           | tr                   |      | 14   |      | ns   | $R_G = 10 \ \Omega R_L$                         | = 37.5 Ω |
| Total Gate Charge                   | QG                   |      | 27   |      | nC   | ID = 7.0 A                                      |          |
| Gate to Source Charge               | Qgs                  |      | 5.5  |      | nC   | $V_{DD} = 400 V$                                |          |
| Gate to Drain Charge                | Qgd                  |      | 12   |      | nC   | Vgs = 10 V                                      |          |
| Body Diode Forward Voltage          | VF(S-D)              |      | 1.0  |      | V    | IF = 7.0 A, VGS                                 | = 0      |
| Reverse Recovery Time               | trr                  |      | 300  |      | ns   | IF = 7.0 A, VGS                                 | = 0      |
| Reverse Recovery Charge             | Qrr                  |      | 1.5  |      | μC   | di/dt = 50 A/µs                                 | 3        |

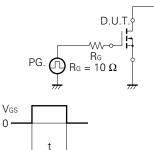
#### Test Circuit 1 Avalanche Capability

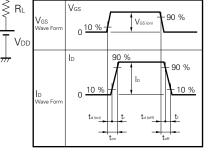


## Test Circuit 3 Gate Charge



#### Test Circuit 2 Switching Time





The application circuits and their parameters are for references only and are not intended for use in actual design-in's.

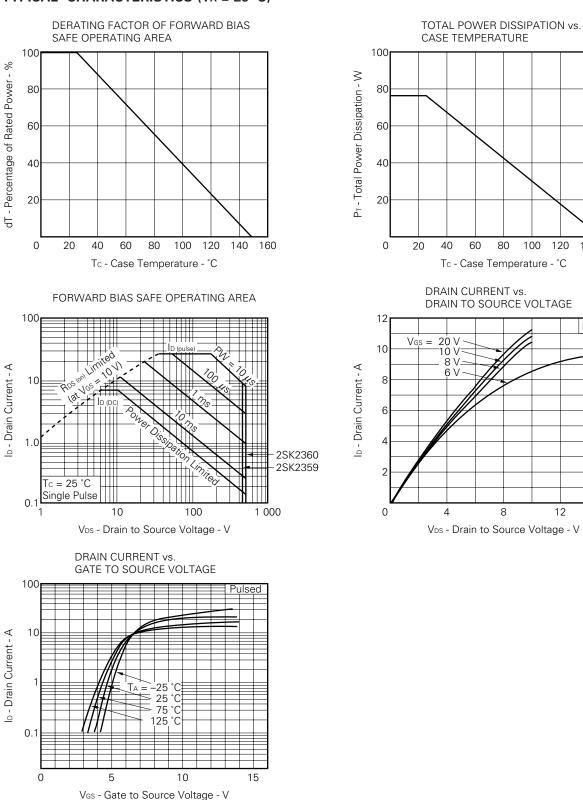
t = 1  $\mu$ s Duty Cycle ≤ 1 %

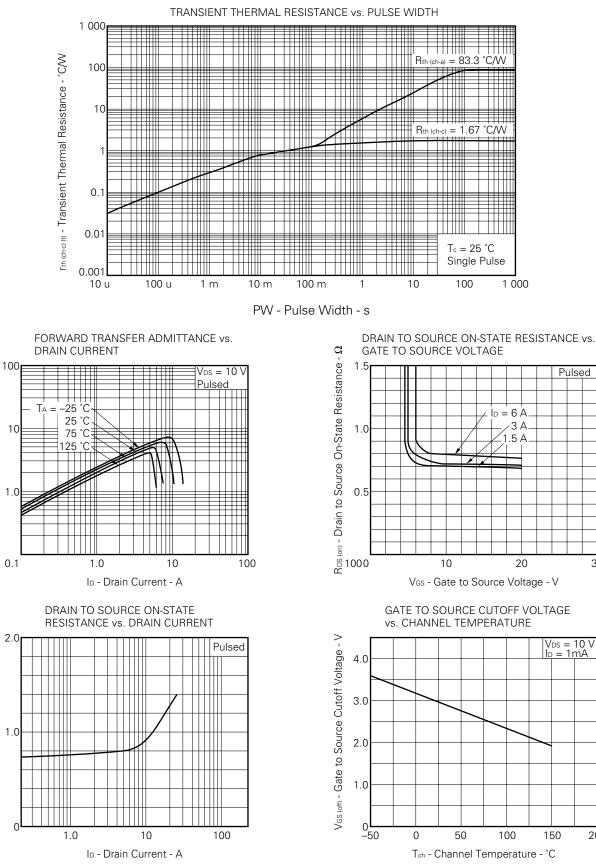
140 160

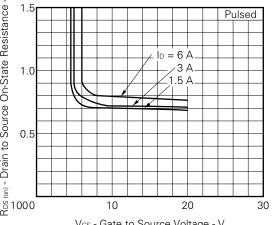
Pulsed

16

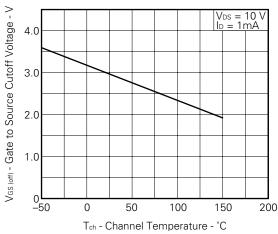
12





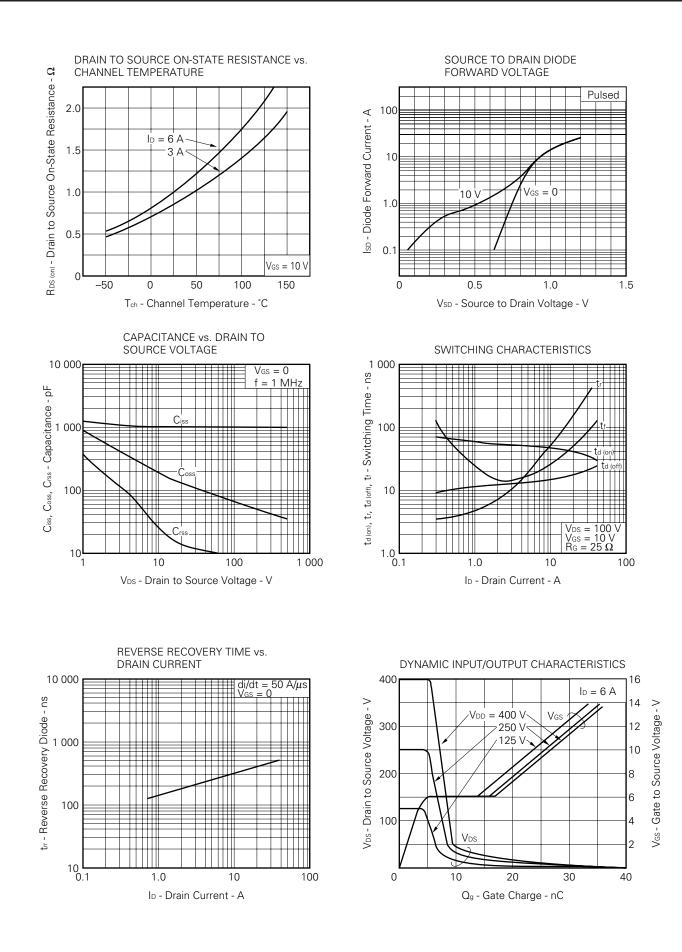


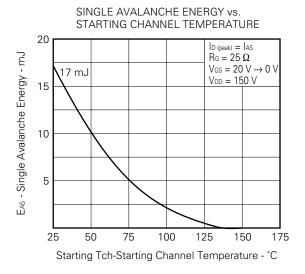
GATE TO SOURCE CUTOFF VOLTAGE

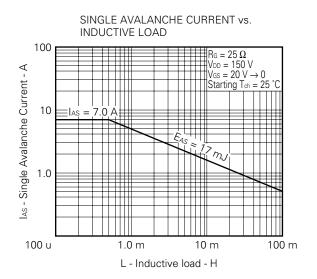


 $R_{\text{DS(on)}}$  - Drain to Source on-State Resistance -  $\Omega$ 

I yfs I - Forward Transfer Admittance - S







#### REFERENCE

| Document Name  | Document No. |
|--|--------------|
| NEC semiconductor device reliability/quality control system.   | TEI-1202     |
| Quality grade on NEC semiconductor devices.                    | IEI-1209     |
| Semiconductor device mounting technology manual.               | IEI-1207     |
| Semiconductor device package manual.                           | IEI-1213     |
| Guide to quality assurance for semiconductor devices.          | MEI-1202     |
| Semiconductor selection guide.                                 | MF-1134      |
| Power MOS FET features and application switching power supply. | TEA-1034     |
| Application circuits using Power MOS FET.                      | TEA-1035     |
| Safe operating area of Power MOS FET.                          | TEA-1037     |

The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device is actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

[MEMO]

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Anti-radioactive design is not implemented in this product.